

# A fast Monte Carlo method for model-based prognostics based on stochastic calculus

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# Introduction

Ingredients of model-based prognostic:

- state-space formulations

$$\dot{x} = f_{\theta}(x, u, \omega)$$

- Monte Carlo (MC) methods

$$x^{(i)} \sim p(X)$$

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- state-space formulations  $\dot{x} = f_{\theta}(x, u, \omega)$
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Some considerations:

- Monte Carlo methods are computationally expensive
- state-space formulations are differential equations with stochastic terms (SDE)

# Introduction

## Contribution of this work

Try to take advantage of stochastic calculus and SDE solutions to accelerate model-based prognostic using Monte Carlo simulations (?).

## Potential

reducing computational time preserving (enhancing) the precision of estimations

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## Summary of model-based prediction

$$\begin{aligned}\dot{x} &= f_{\theta}(x, u, \omega) \\ &\downarrow \\ x_k &= x_{k-1} + f_{\theta}(x_{k-1}, u_{k-1}, \omega_{k-1}) \Delta t_k\end{aligned}$$

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**Input:**  $x_k^{(i)} \sim p(X_k), I$

**Output:**  $x_{k+I}^{(i)} \sim p(X_{k+I})$

**for each**  $x_k^{(i)} \sim p(X_k)$  **do**

**for each**  $\tau \in \{1, \dots, I\}$  **do**

$\omega_{k+\tau-1}^{(i)} \sim p(\Omega_{k+\tau-1})$

$x_{k+\tau}^{(i)} = x_{k+\tau-1}^{(i)} + f_{\theta}(x_{k+\tau-1}^{(i)}, u_{k+\tau-1}, \omega_{k+\tau-1}^{(i)}) \Delta t_{k+\tau-1}$

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# Using stochastic calculus properties in model-based prediction

State-space model utilized in prognostic (additive noise case)

$$\dot{x}_t = f_{\theta}(x_t, u_t) + \omega_t$$

$$x_k = x_{k-1} + f_{\theta}(x_{k-1}, u_{k-1}) \Delta t_k + \omega_{k-1} \Delta t_k$$

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Typical SDE formulation

$$\dot{X}_t = f_{\theta}(X_t, U_t) + \sigma(t, X_t) \xi_t$$

$$X_t = X_0 + \int_0^t f_{\theta}(X_s, U_s) ds + \int_0^t \sigma(s, X_s) dB_s$$

$$X_k = X_0 + \sum_{s=0}^{k-1} f_{\theta}(X_s, U_s) \Delta t_s + \sum_{s=0}^{k-1} \sigma(s, X_s) \Delta B_s$$

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## Considerations

under certain assumptions (e.g.,  $\sigma \neq \sigma(X_t)$ ), we can compute the SDE terms separately  
and we can find similarities between noise term and the diffusion term

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# Using stochastic calculus properties in model-based prediction

Let us consider  $\sigma(t, X_t) = \sigma$  in the SDE:

$$\int_0^t \sigma dB \approx \sum_{s=0}^{k-1} \sigma \Delta B_s$$

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$$\int_0^t \sigma dB \approx \sum_{s=0}^{k-1} \sigma \Delta B_s$$

If we assume  $\omega \sim \mathcal{N}(0, \sigma)$  in the state-space model:

$$\omega_{k-1} \Delta t_k = \sigma z_{k-1} \Delta t_k = \sigma \Delta B_k$$

# Using stochastic calculus properties in model-based prediction

Some useful properties of Brownian motion  $B$ :

- $dB \sim \mathcal{N}(0, dt) \rightarrow dB^{(i)} = \sqrt{dt} z^{(i)}$
- $B_{t_2} - B_{t_1} \sim \mathcal{N}(0, t_2 - t_1)$

# Applications

Case study 1: prognostic of electrolytic capacitors<sup>1</sup>:

$$\dot{C}_I = \alpha C_I - \alpha\beta + \omega$$

$$C_I(t) = e^{\alpha t} \left( -\beta + \beta e^{-\alpha t} + \int_0^t \sigma e^{-\alpha s} dB_s \right)$$

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<sup>1</sup>Celaya J, Kulkarni C, Biswas G, Saha S, Goebel K. A model-based prognostic methodology for electrolytic capacitors based on electrical overstress accelerated aging. Annual Conference of the PHM Society 2011; 25-29 Sept. 2011

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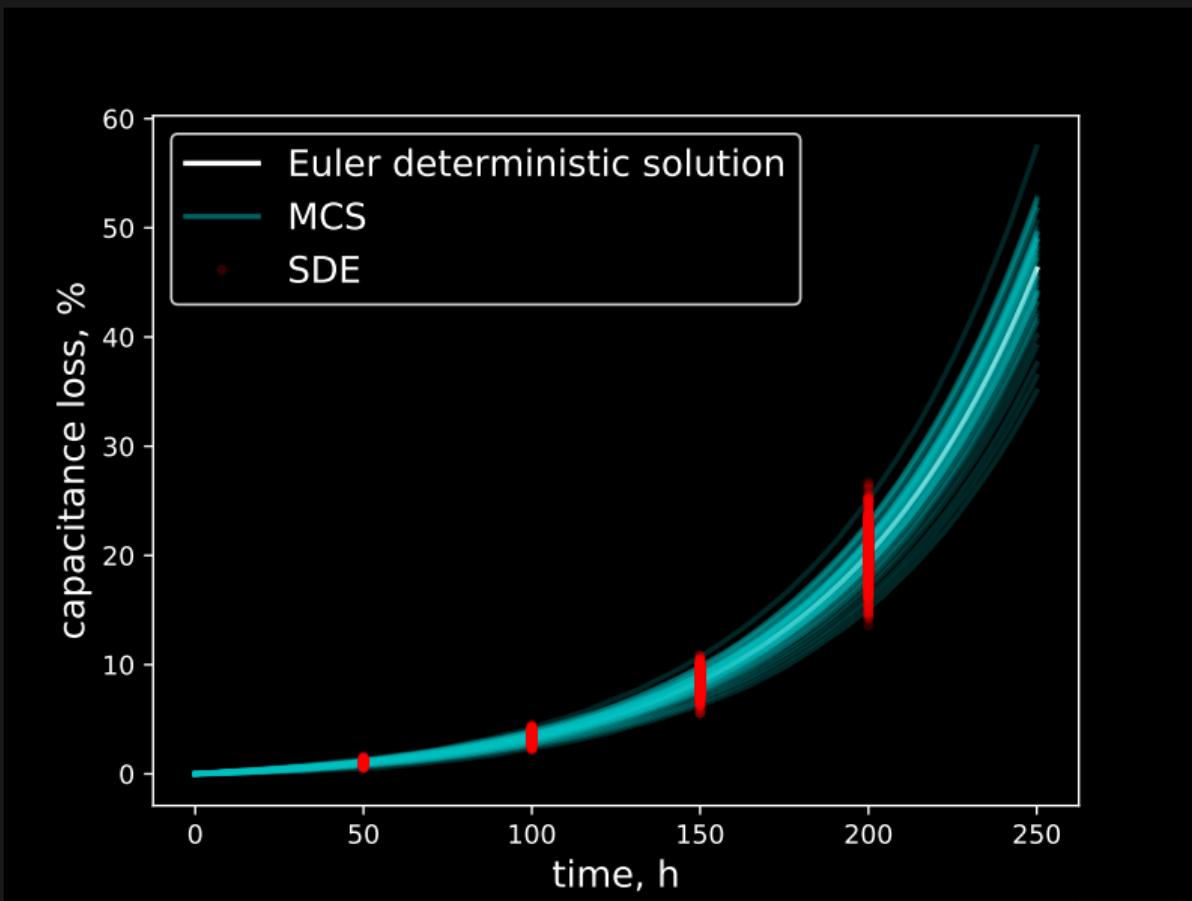
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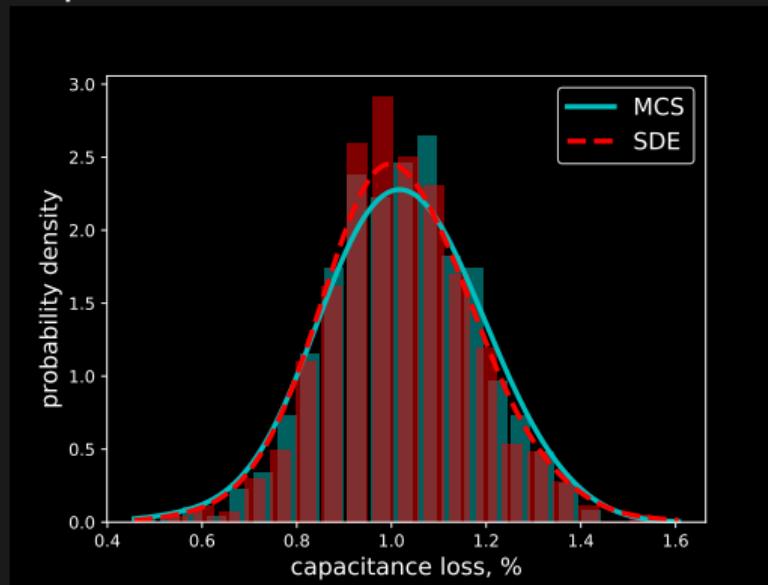
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# Case study 1: prognostic of electrolytic capacitors

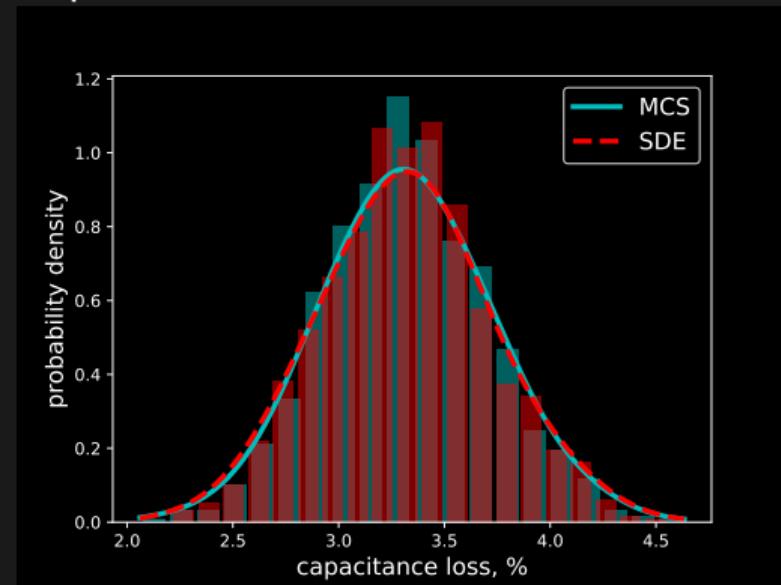


# Case study 1: prognostic of electrolytic capacitors

Capacitance loss at  $t = 50$  h

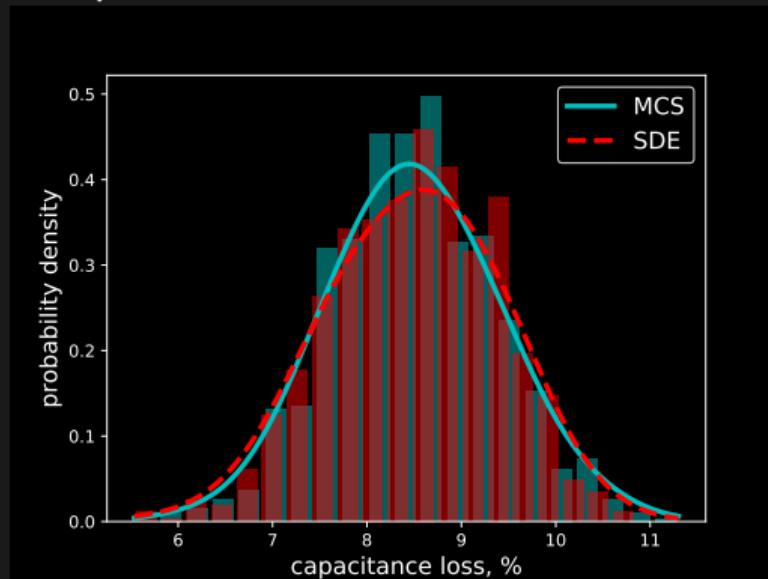


Capacitance loss at  $t = 100$  h

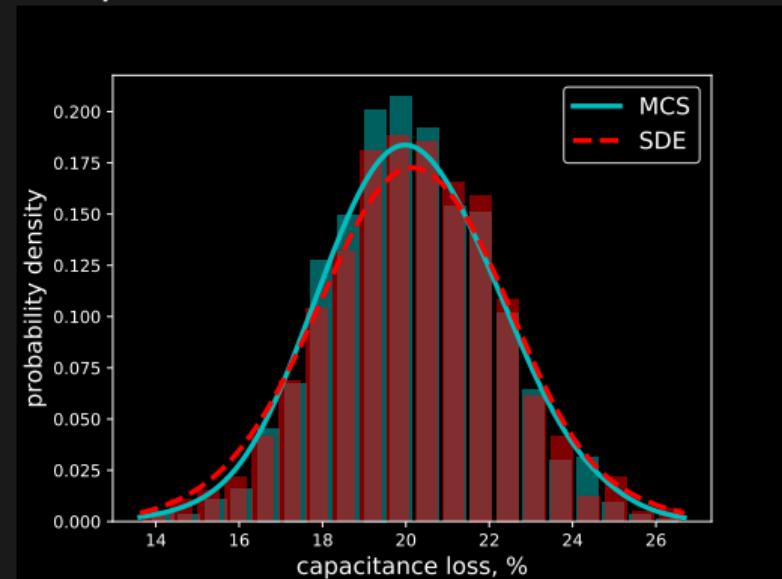


# Case study 1: prognostic of electrolytic capacitors

Capacitance loss at  $t = 150$  h



Capacitance loss at  $t = 200$  h



## Case study 1: prognostic of electrolytic capacitors

| time [h] | $\text{KL}(p_{\text{MCS}}    p_{\text{SDE}})$ | Hyp. test @ $\nu = 0.05$                              |  | computing time [s] |       |
|----------|---|---|--|--------------------|-------|
|          |   | $H_0 : \mu_{C_l, \text{MCS}} = \mu_{C_l, \text{SDE}}$ | $H_1 : \mu_{C_l, \text{MCS}} \neq \mu_{C_l, \text{SDE}}$ | MCS                | SDE   |
| 50       | 0.00405                                       | 0.305   | $T$<br>$t_{\nu/2, 2N-2}$                                 | 0.230              | 0.243 |
| 100      | 0.000703                                      | 0.441   |  | 0.427              | 0.468 |
| 150      | 0.00429                                       | 0.095   |  | 0.627              | 0.700 |
| 200      | 0.00514                                       | 1.187   |  | 0.819              | 0.990 |

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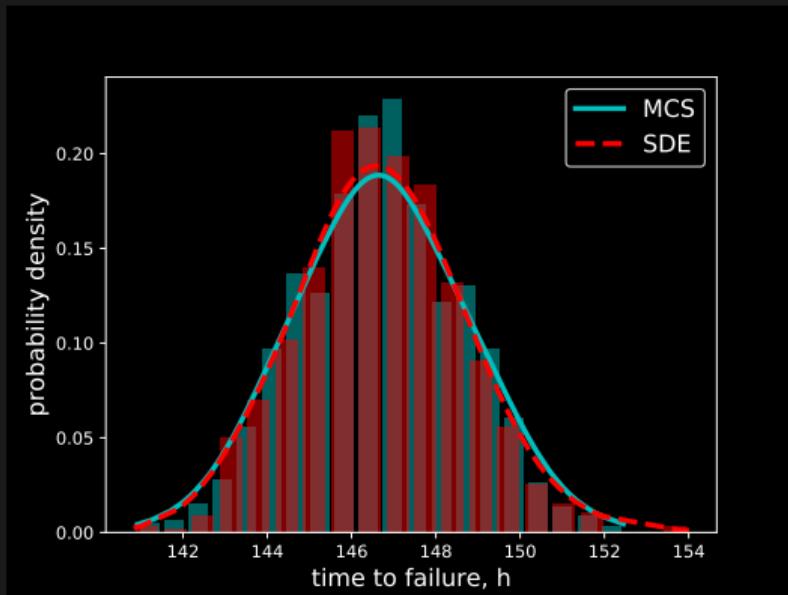
Time-to-failure (TTF) prediction:

$$\mathbb{E}[T_F] = \frac{1}{\alpha} \ln \left( 1 - \frac{C_{I,th}}{\beta} \right)$$

$$T_F^{(i)} = \frac{1}{\alpha} \ln \frac{C_{I,th} - \beta}{\int_0^{\mathbb{E}[T_f]} \sigma e^{-\alpha s} dB_s - \beta} \quad \forall i = 1, \dots, N$$

# Case study 1: prognostic of electrolytic capacitors

time-to-failure pdf,  $C_{l,th} = 8\%$



| Hyp. test @ $\nu = 0.05$                        |  |
|---|--|
| $H_0$   | $H_1$  |
| $\mu_{C_l, \text{MCS}} = \mu_{C_l, \text{SDE}}$ | $\mu_{C_l, \text{MCS}} \neq \mu_{C_l, \text{SDE}}$ |
| $T$   | $t_{\nu/2, 2N-2}$                                  |
| 0.001513  | 0.049      1.961                                   |

| computing time [s] |       |
|--------------------|-------|
| MCS                | SDE   |
| 706.792            | 0.592 |

# Applications

Case study 2: predicting the remaining time to discharge of Lithium-ion batteries using a simple state-of-charge (SOC) model<sup>2</sup>:

$R$  = internal resistance,  $E$  = total energy delivered,  $S$  = SOC,  $\omega \sim \mathcal{N}(0, \sigma^2)$

$$\dot{R} = \omega_R$$

$$\dot{S} = -\frac{P}{E} + \omega_S$$

$$\dot{E} = \omega_E$$

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<sup>2</sup>Sierra G, Orchard M, Goebel K, Kulkarni C. Battery Health Management for Small-size Rotary-wing Electric Unmanned Aerial Vehicles: An Efficient Approach for Constrained Computing Platforms. Reliability Engineering & System Safety 2018

## Case study 2: remaining time to discharge of Lithium-ion batteries

We can directly sample from the pdfs of  $R$  and  $E$  at time  $t$ :

$$R_t^{(i)} \sim \mathcal{N}(0, \sigma_R^2 t)$$

$$E_t^{(i)} \sim \mathcal{N}(0, \sigma_E^2 t)$$

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$$\begin{aligned} R_t^{(i)} &\sim \mathcal{N}(0, \sigma_R^2 t) \\ E_t^{(i)} &\sim \mathcal{N}(0, \sigma_E^2 t) \end{aligned}$$

the  $i$ -th SOC sample becomes:

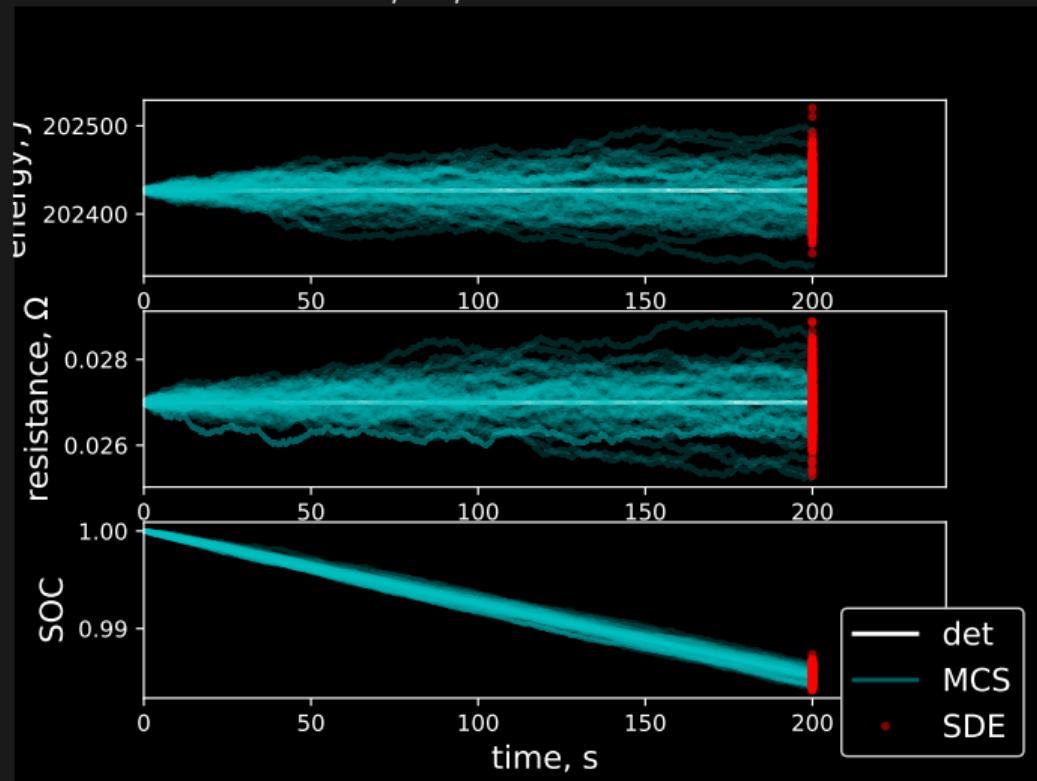
$$S_t^{(i)} = S_0 - \frac{P}{E_t^{(i)}} t + \sigma_S \sqrt{t} z^{(i)}$$

Current  $i_t$  and voltage  $V_t$  are then estimated from  $R$  and  $S$

$$V_t = v_{oc,t}(S_t) - i_t(R_t, P_t) R_t + \omega_V$$

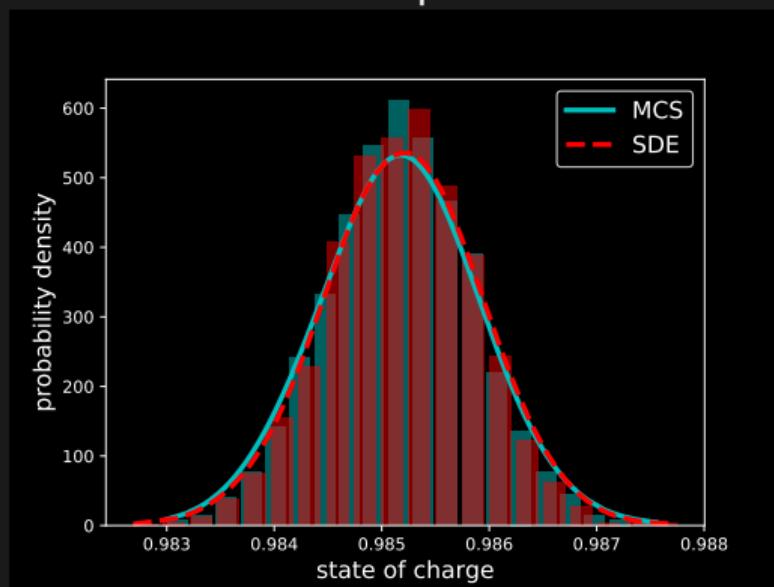
## Case study 2: remaining time to discharge of Lithium-ion batteries

$E, R, S$  over time

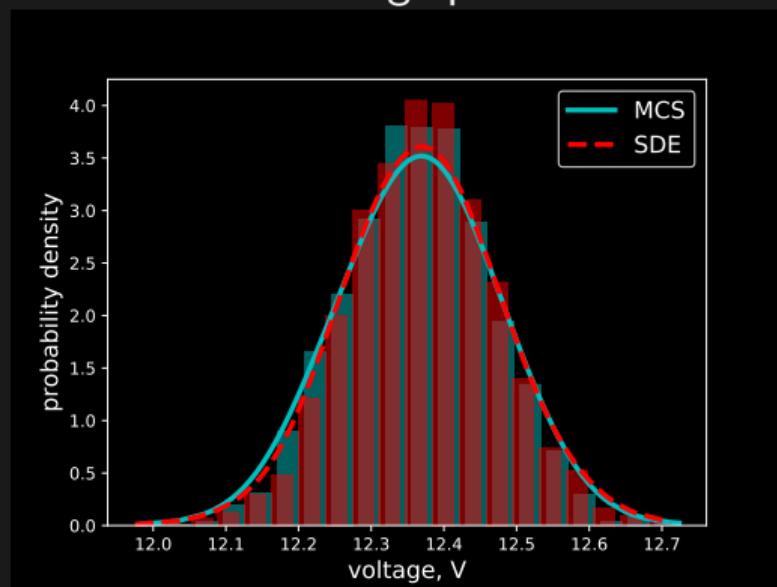


# Case study 2: remaining time to discharge of Lithium-ion batteries

SOC pdf



Voltage pdf



## Case study 2: remaining time to discharge of Lithium-ion batteries

Comparing SOC distributions at  $t = 200$  s

| $\text{KL}(p_{\text{MCS}}    p_{\text{SDE}})$ | $\tilde{t}$ | $t_{\nu/2, 2N-2}$ | computing time [s] |       |
|---|-------------|-------------------|--------------------|-------|
|   |             |                   | MCS                | SDE   |
| 0.00138                                       | 1.454       | 1.961             | 2.978              | 0.009 |

# Applications

Case study 3: fatigue damage prognosis of cracked structure under constant amplitude fatigue loading, using Paris' law:

$$\frac{da}{dn} = C'a^\gamma e^\omega$$

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$$\frac{1}{C'} \int_{a_0}^{a_f} \frac{1}{a^\gamma} da = \int_0^{n_f} e^{\omega s} ds$$

# Applications

Case study 3: fatigue damage prognosis of cracked structure under constant amplitude fatigue loading, using Paris' law:

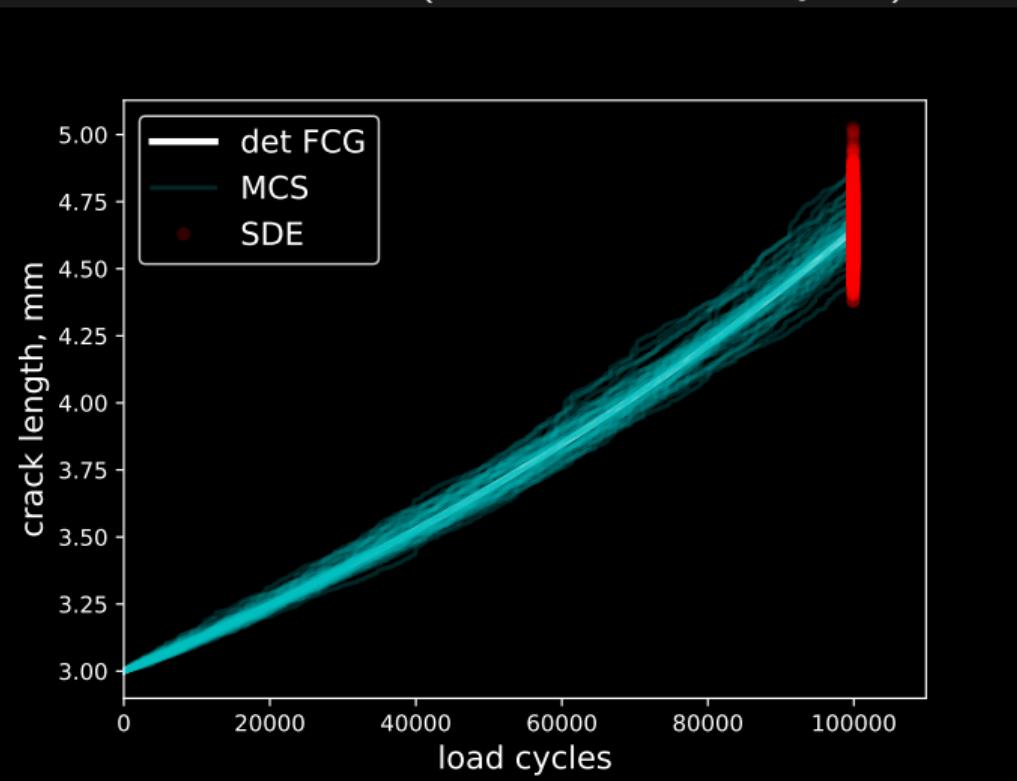
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$$\int_0^{\mathbb{E}[n_f]} e^{\omega_s} ds \approx \sum_{s=0}^{k-1} e^{\omega^{(i)}} \Delta n_s \quad \forall i = 1, \dots, N$$

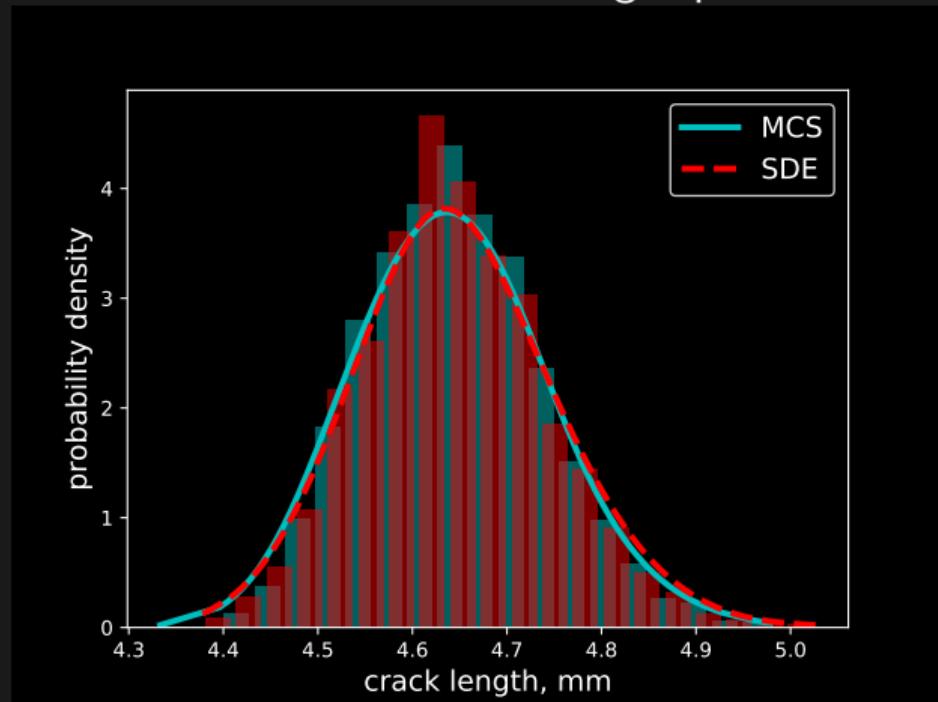
# Case study 3: fatigue damage prognosis of cracked structure

FCG over time ( $n = 100000$  load cycles)



# Case study 3: fatigue damage prognosis of cracked structure

crack length pdf,  $n = 100000$  load cycles



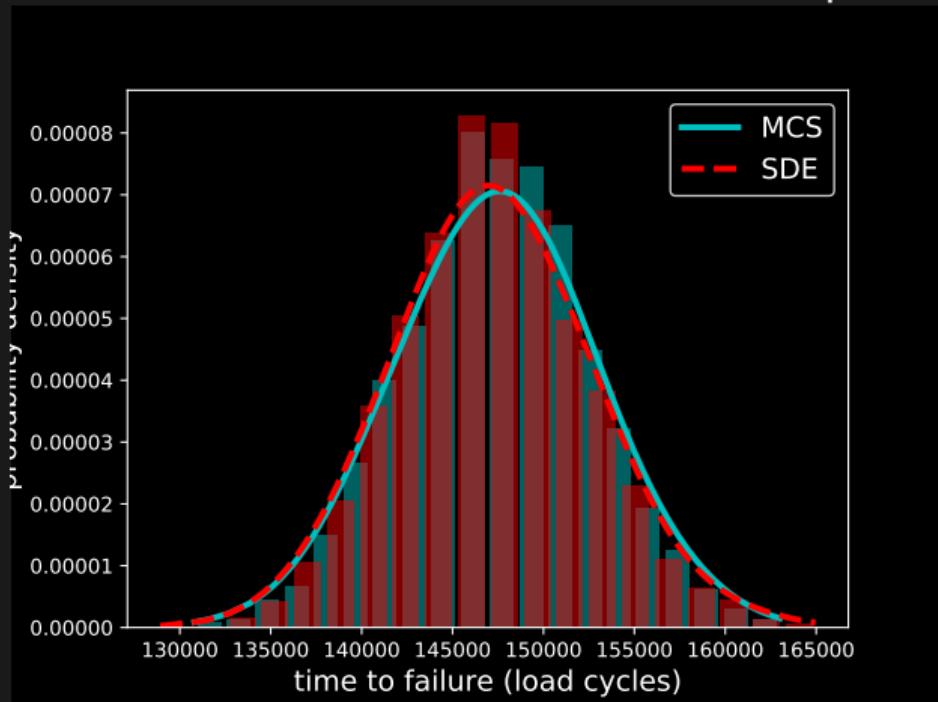
SDE method does not help in this case:

| $\text{KL}(p_{\text{MCS}}    p_{\text{SDE}})$ | $\tilde{t}$ | $t_{\nu/2, 2N-2}$ |
|---|-------------|-------------------|
| 0.00198                                       | 1.748       | 1.961             |

| computing time [s] |       |
|--------------------|-------|
| MCS                | SDE   |
| 0.180              | 0.205 |

# Case study 3: fatigue damage prognosis of cracked structure

time-to-failure pdf,  $a_{th} = 6 \text{ mm}$



| $\text{KL}(p_{\text{MCS}}    p_{\text{SDE}})$ | $\tilde{t}$ | $t_{\nu/2, 2N-2}$ |
|---|-------------|-------------------|
| 0.00180                                       | 1.579       | 1.961             |

| computing time [s] |       |
|--------------------|-------|
| MCS                | SDE   |
| 29.617             | 0.156 |

# Conclusions

## To summarize

- Fast MC approximation of prediction distributions using stochastic calculus
- **Pro:** pdfs of interest can be computed much faster
- **Cons:** limited to relatively simple models
- **Cons:** does not generalize easily, performance are model-dependent

## Future works

- generalize to  $x_0 \sim p(X_0)$  and  $\theta \sim p(\theta)$  before deployment.
- extension to vector SDEs and other model classes, whenever possible
- sensitivity analysis: number of samples, number of prediction steps, etc.

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